

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed for N-CDMA base station applications with frequencies from 1805 to 1880 MHz. Suitable for TDMA, CDMA and multicarrier amplifier applications. To be used in Class AB for PCN-PCS/cellular radio and WLL applications.

- Typical 2-Carrier N-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQ} = 1200$ mA, $P_{out} = 29$ Watts Avg., Full Frequency Band, IS-95 CDMA (Pilot, Sync, Paging, Traffic Codes 8 Through 13) Channel Bandwidth = 1.2288 MHz. PAR = 9.8 dB @ 0.01% Probability on CCDF.
 Power Gain — 16 dB
 Drain Efficiency — 27.5%
 IM3 @ 2.5 MHz Offset — -36 dBc in 1.2288 MHz Bandwidth
 ACPR @ 885 kHz Offset — -50.5 dBc in 30 kHz Bandwidth
- Capable of Handling 10:1 VSWR, @ 28 Vdc, 1840 MHz, 140 Watts CW Output Power

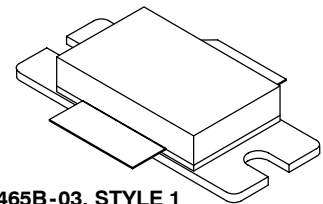
Features

- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified Up to a Maximum of 32 V_{DD} Operation
- Integrated ESD Protection
- Lower Thermal Resistance Package
- Designed for Lower Memory Effects and Wide Instantaneous Bandwidth Applications
- Low Gold Plating Thickness on Leads, 40 μ " Nominal.
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

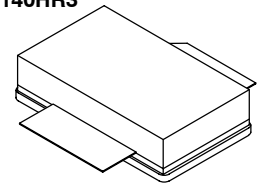


MRF6S18140HR3
MRF6S18140HSR3

1805-1880 MHz, 29 W AVG., 28 V
2 x N-CDMA
LATERAL N-CHANNEL
RF POWER MOSFETs



CASE 465B-03, STYLE 1
NI-880
MRF6S18140HR3



CASE 465C-02, STYLE 1
NI-880S
MRF6S18140HSR3

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +68	Vdc
Gate-Source Voltage	V_{GS}	-0.5, +12	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	$^{\circ}C$
Case Operating Temperature	T_C	150	$^{\circ}C$
Operating Junction Temperature (1,2)	T_J	225	$^{\circ}C$

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 80 $^{\circ}C$, 140 W CW Case Temperature 73 $^{\circ}C$, 29 W CW	$R_{\theta JC}$	0.31 0.35	$^{\circ}C/W$

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2 (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

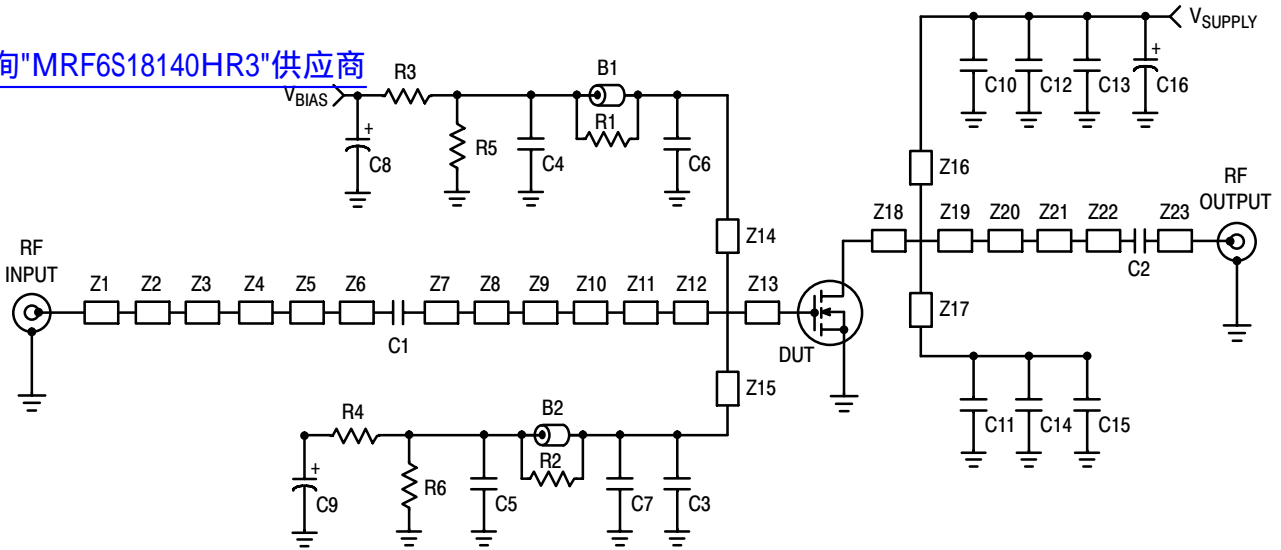
Table 4. Electrical Characteristics ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Off Characteristics					
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 68\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28\text{ Vdc}$, $V_{GS} = 0\text{ Vdc}$)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current ($V_{GS} = 5\text{ Vdc}$, $V_{DS} = 0\text{ Vdc}$)	I_{GSS}	—	—	1	μAdc
On Characteristics					
Gate Threshold Voltage ($V_{DS} = 10\text{ Vdc}$, $I_D = 300\ \mu\text{Adc}$)	$V_{GS(th)}$	1.2	2	2.7	Vdc
Gate Quiescent Voltage ($V_{DS} = 28\text{ Vdc}$, $I_D = 1200\text{ mAdc}$, Measured in Functional Test)	$V_{GS(Q)}$	2	2.7	3.8	Vdc
Drain-Source On-Voltage ($V_{GS} = 10\text{ Vdc}$, $I_D = 3\text{ Adc}$)	$V_{DS(on)}$	0.1	0.22	0.3	Vdc
Dynamic Characteristics (1)					
Reverse Transfer Capacitance ($V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$)	C_{rss}	—	2.2	—	pF
Output Capacitance ($V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$)	C_{oss}	—	685	—	pF

Functional Tests (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 1200\text{ mA}$, $P_{out} = 29\text{ W Avg.}$, $f_1 = 1805\text{ MHz}$, $f_2 = 1807.5\text{ MHz}$ and $f_1 = 1877.5\text{ MHz}$, $f_2 = 1880\text{ MHz}$, 2-Carrier N-CDMA, 1.2288 MHz Channel Bandwidth Carriers. ACPR measured in 30 kHz Channel Bandwidth @ $\pm 885\text{ kHz}$ Offset. IM3 measured in 1.2288 MHz Channel Bandwidth @ $\pm 2.5\text{ MHz}$ Offset. PAR = 9.8 dB @ 0.01% Probability on CCDF.

Power Gain	G_{ps}	15	16	18	dB
Drain Efficiency	η_D	25.5	27.5	—	%
Intermodulation Distortion	IM3	—	-36	-34.5	dBc
Adjacent Channel Power Ratio	ACPR	—	-50.5	-48	dBc
Input Return Loss	IRL	—	-10.5	—	dB

1. Part internally matched both on input and output.



Z1	0.166" x 0.082" Microstrip	Z13	0.108" x 1.070" Microstrip
Z2	0.250" x 0.334" Microstrip	Z14	0.960" x 0.046" Microstrip
Z3	0.140" x 0.340" Microstrip	Z15	0.084" x 0.046" Microstrip
Z4	0.092" x 0.164" Microstrip	Z16	0.996" x 0.080" Microstrip
Z5	0.130" x 0.234" Microstrip	Z17	1.015" x 0.080" Microstrip
Z6	0.109" x 0.082" Microstrip	Z18	0.099" x 1.070" Microstrip
Z7	0.070" x 0.082" Microstrip	Z19	0.516" x 1.070" Microstrip
Z8	0.350" x 0.644" Microstrip	Z20	0.292" x 0.288" Microstrip
Z9	0.092" x 0.420" Microstrip	Z21	0.198" x 0.114" Microstrip
Z10	0.720" x 0.082" Microstrip	Z22	0.372" x 0.080" Microstrip
Z11	0.090" x 0.485" x 0.580" Taper	Z23	1.181" x 0.080" Microstrip
Z12	0.342" x 1.070" Microstrip	PCB	DS Electronics GX0300, 0.030", $\epsilon_r = 2.55$

Figure 1. MRF6S18140HR3(HSR3) Test Circuit Schematic

Table 5. MRF6S18140HR3(HSR3) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1, B2	47 Ω , 100 MHz Small Ferrite Beads, Surface Mount	2743019447	Fair-Rite
C1, C2	39 pF Chip Capacitors	700B390FW500XT	ATC
C3	0.1 pF Chip Capacitor	100B0R1BP500X	ATC
C4, C5, C12, C13, C14, C15	10 μ F, 50 V Chip Capacitors	GRM55DR61H106KA88B	Murata
C6, C7, C10, C11	9.1 pF Chip Capacitors	600B9R1BT250XT	ATC
C8, C9	47 μ F, 50 V Electrolytic Capacitors	MVK50VC47RM8X10TP	United Chemi-Con
C16	470 μ F, 63 V Electrolytic Capacitor	NACZF471M63V	Nippon Chemi-Con
R1, R2	12 Ω , 1/8 W Resistors	CRCW120612R0F100	Dale/Vishay
R3, R4	1.0 K Ω , 1/8 W Resistors	CRCW12061001F100	Dale/Vishay
R5, R6	560 K Ω , 1/8 W Chip Resistors	CRCW12065602F101	Dale/Vishay

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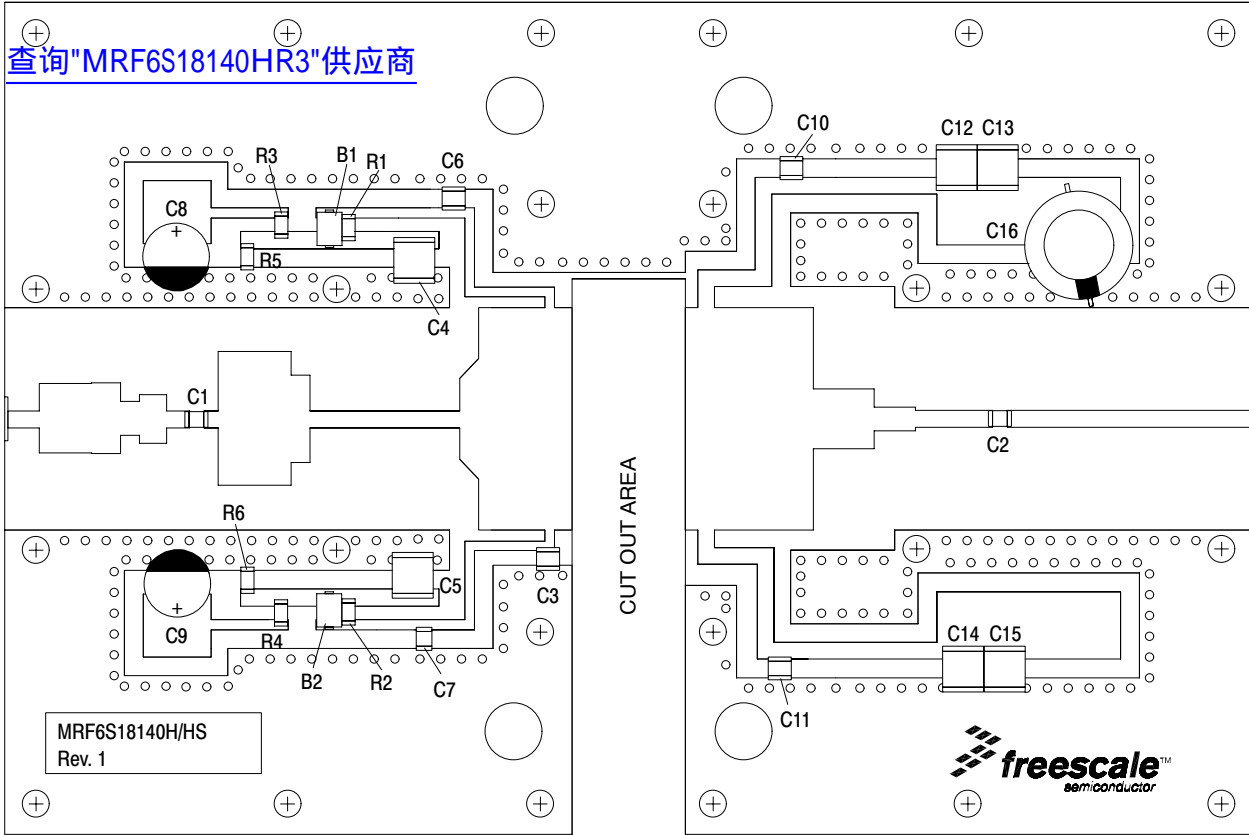


Figure 2. MRF6S18140HR3(HSR3) Test Circuit Component Layout

TYPICAL CHARACTERISTICS

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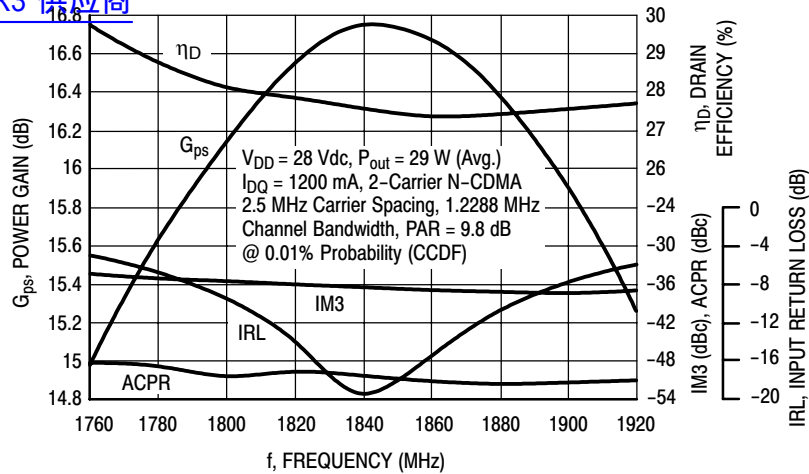


Figure 3. 2-Carrier N-CDMA Broadband Performance @ $P_{out} = 29$ Watts Avg.

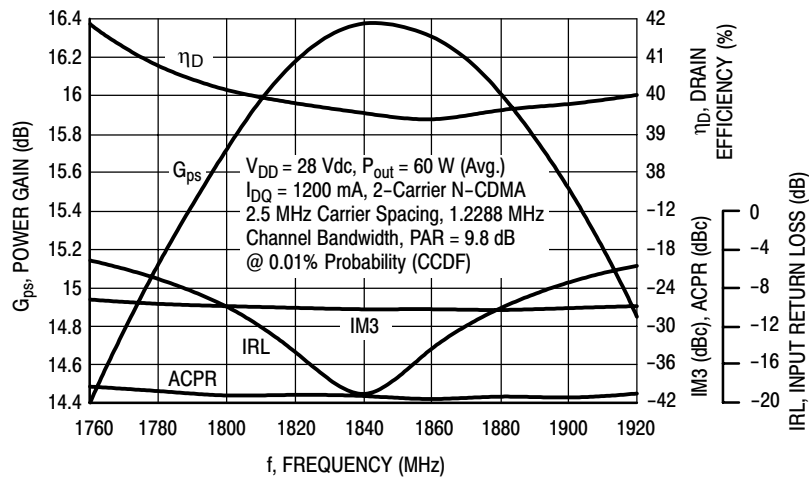


Figure 4. 2-Carrier N-CDMA Broadband Performance @ $P_{out} = 60$ Watts Avg.

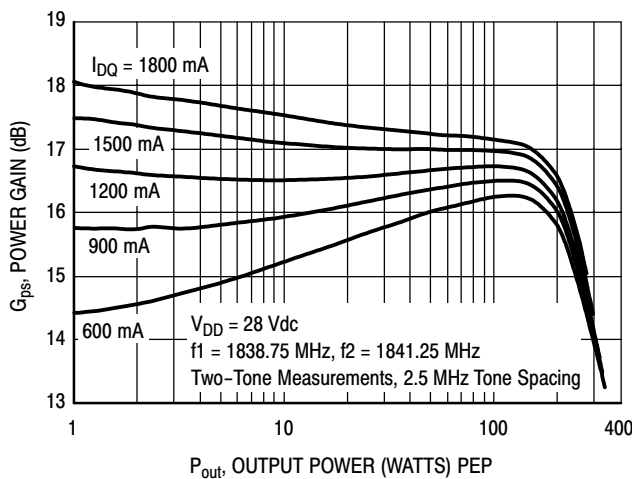


Figure 5. Two-Tone Power Gain versus Output Power

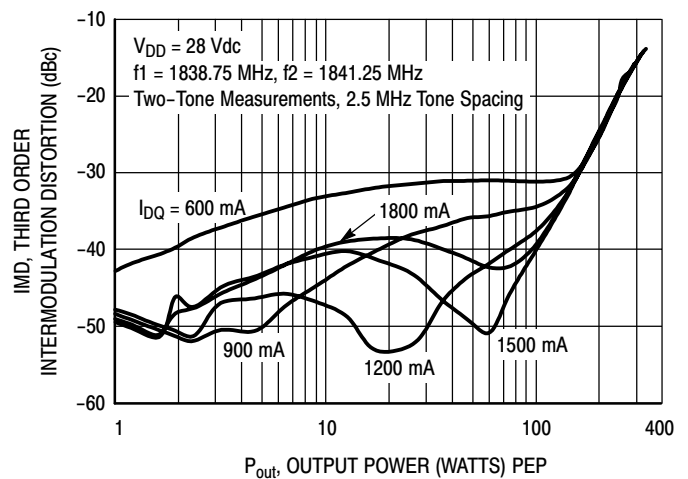


Figure 6. Third Order Intermodulation Distortion versus Output Power

MRF6S18140HR3 MRF6S18140HSR3

TYPICAL CHARACTERISTICS

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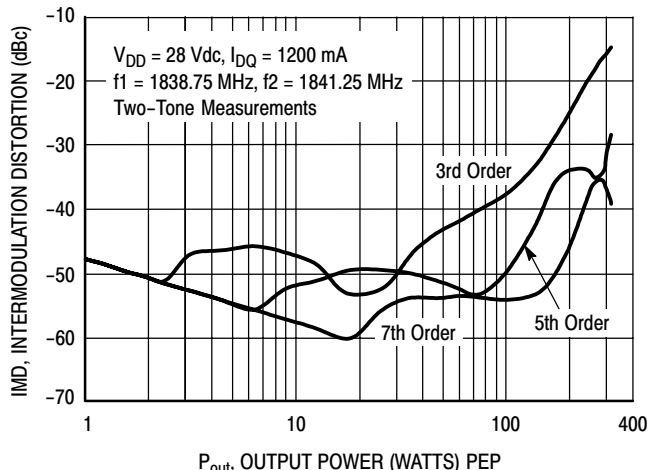


Figure 7. Intermodulation Distortion Products versus Output Power

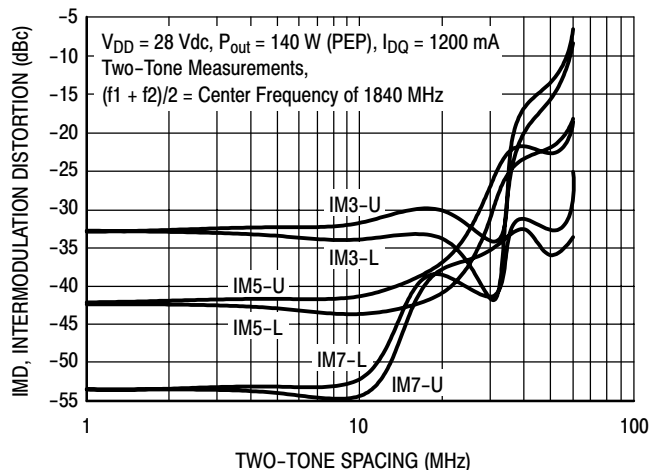


Figure 8. Intermodulation Distortion Products versus Tone Spacing

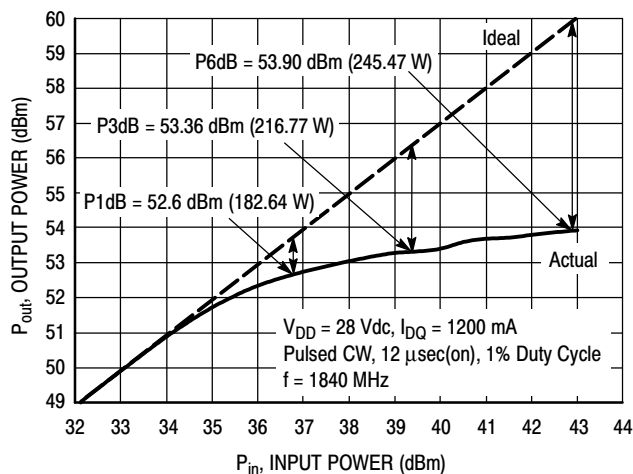


Figure 9. Pulsed CW Output Power versus Input Power

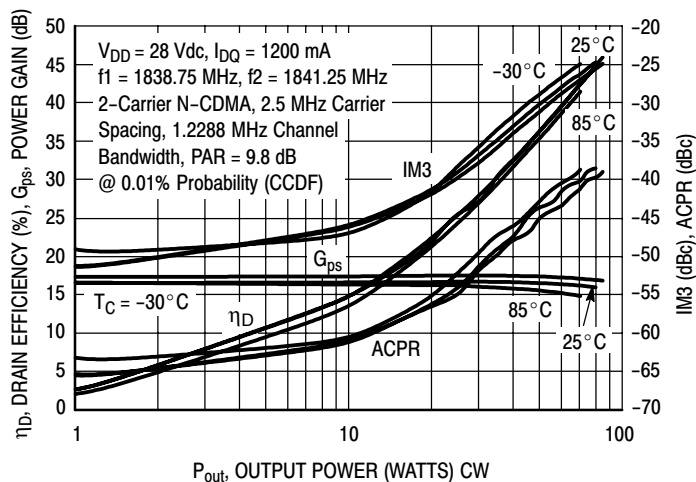


Figure 10. 2-Carrier N-CDMA ACPR, IM3, Power Gain and Drain Efficiency versus Output Power

TYPICAL CHARACTERISTICS

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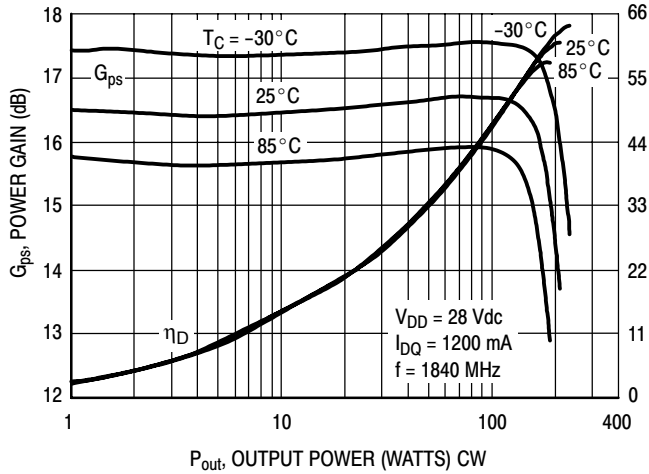


Figure 11. Power Gain and Drain Efficiency versus CW Output Power

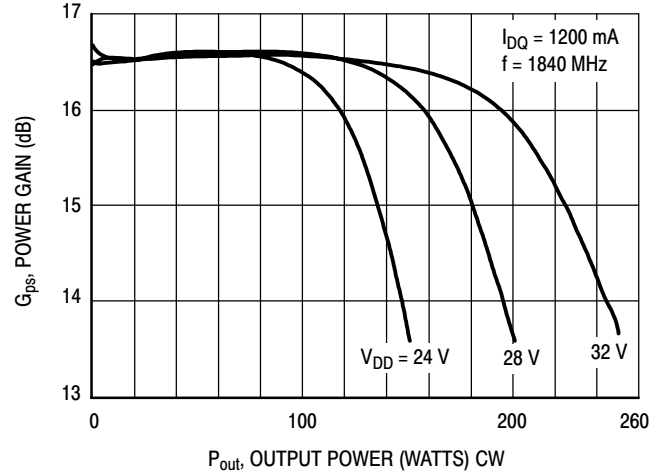
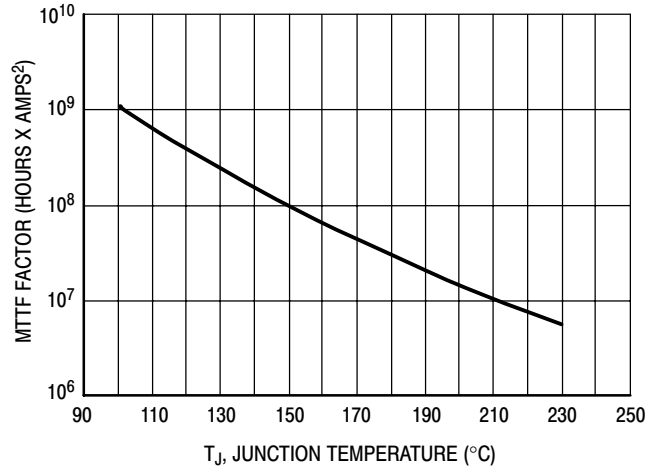


Figure 12. Power Gain versus Output Power



This above graph displays calculated MTTF in hours x ampere² drain current. Life tests at elevated temperatures have correlated to better than $\pm 10\%$ of the theoretical prediction for metal failure. Divide MTTF factor by I_D^2 for MTTF in a particular application.

Figure 13. MTTF Factor versus Junction Temperature

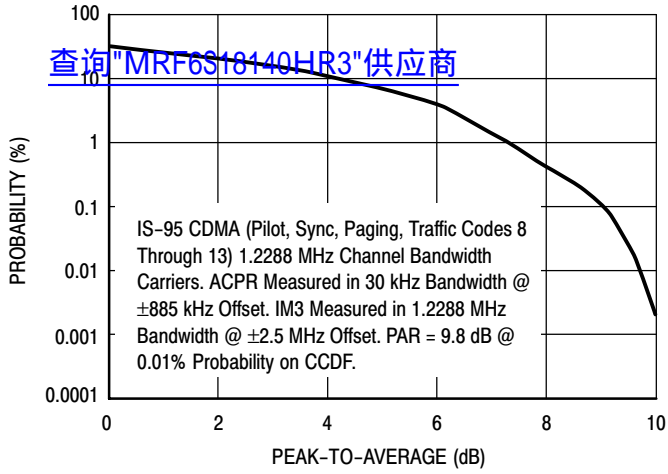


Figure 14. 2-Carrier CCDF N-CDMA

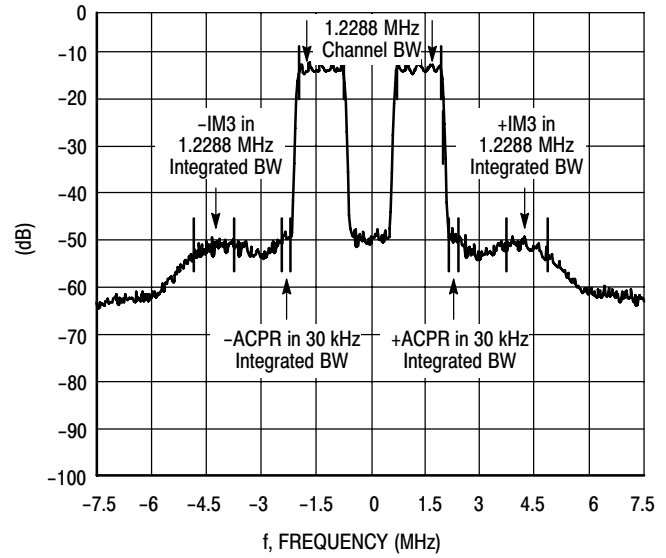
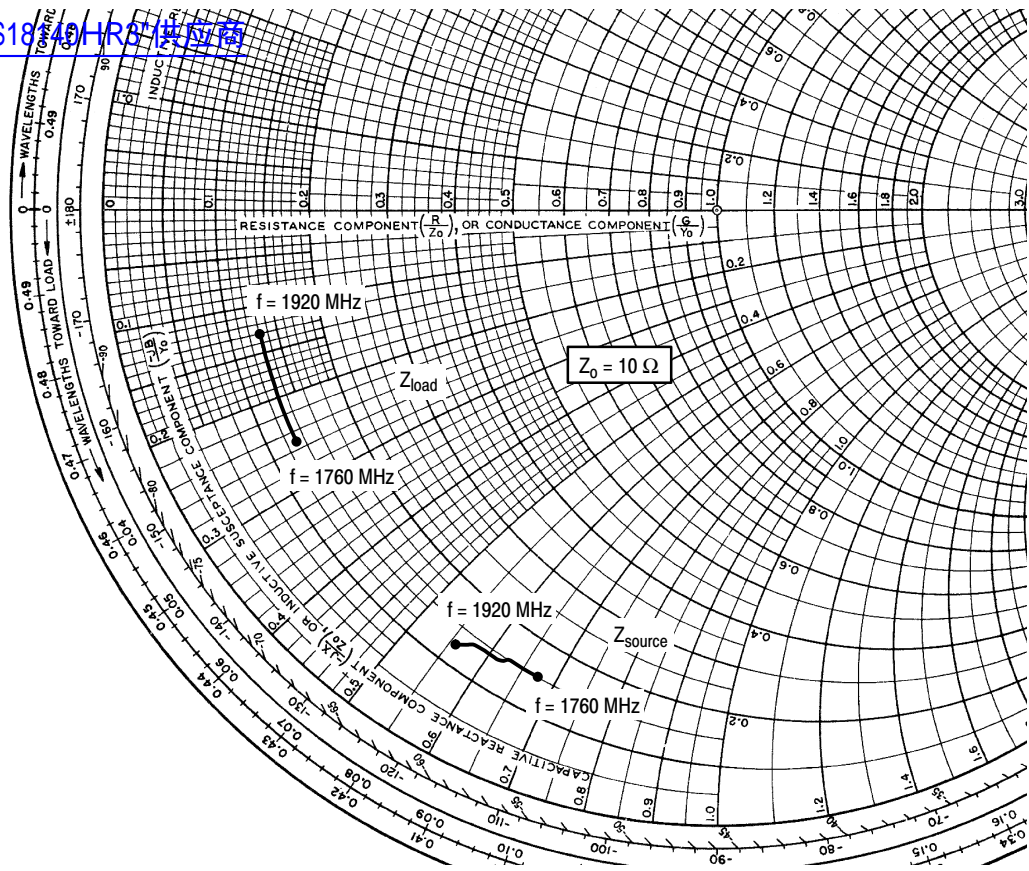


Figure 15. 2-Carrier N-CDMA Spectrum



$V_{DD} = 28 \text{ Vdc}$, $I_{DQ} = 1200 \text{ mA}$, $P_{out} = 29 \text{ W Avg.}$

f MHz	Z_{source} Ω	Z_{load} Ω
1760	1.454 - j6.703	1.344 - j2.479
1780	1.465 - j6.511	1.338 - j2.299
1800	1.467 - j6.336	1.333 - j2.129
1820	1.448 - j6.193	1.325 - j1.966
1840	1.440 - j6.049	1.308 - j1.801
1860	1.414 - j5.938	1.301 - j1.687
1880	1.377 - j5.827	1.303 - j1.550
1900	1.311 - j5.710	1.301 - j1.419
1920	1.231 - j5.583	1.289 - j1.303

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

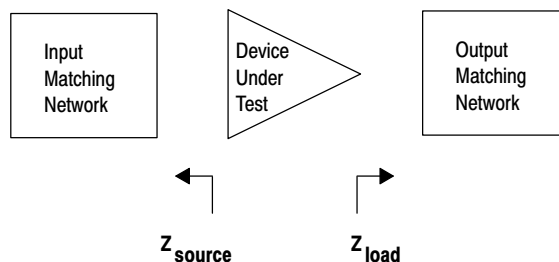
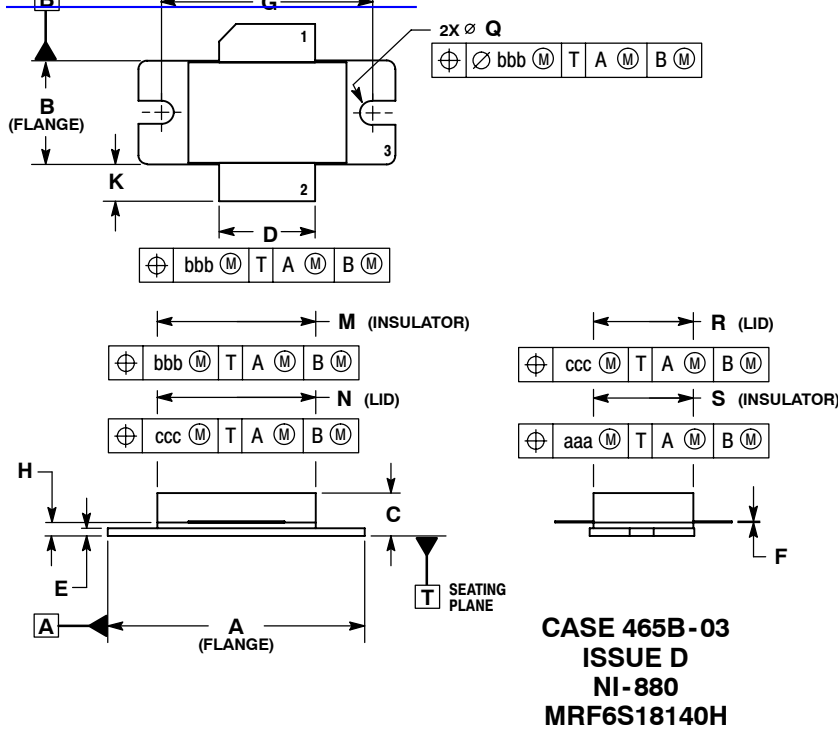


Figure 16. Series Equivalent Source and Load Impedance

PACKAGE DIMENSIONS

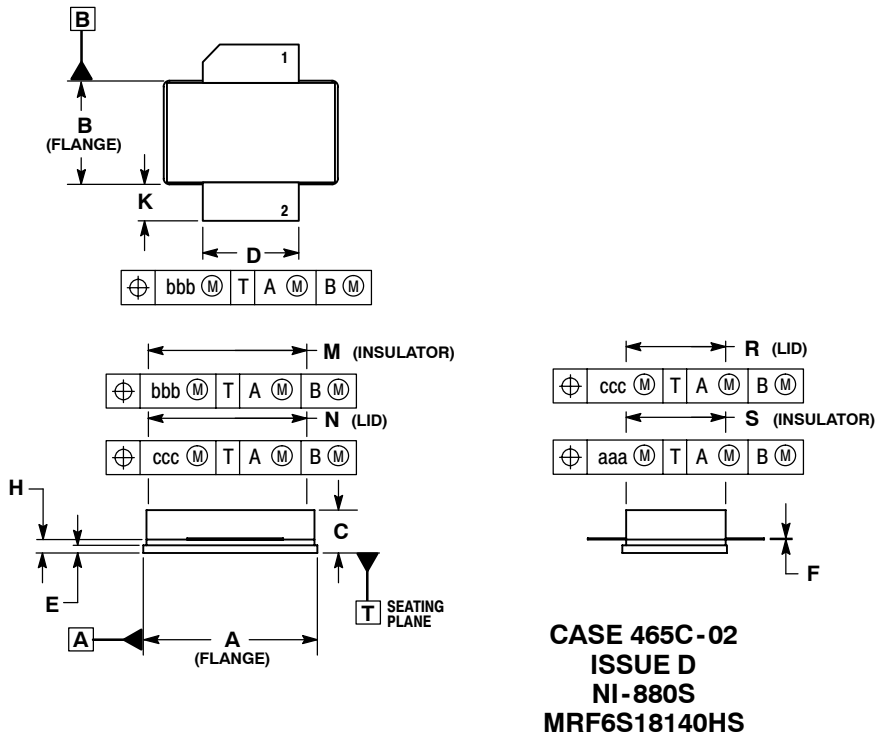
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- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.
 4. DELETED

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16
B	0.535	0.545	13.6	13.8
C	0.147	0.200	3.73	5.08
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
G	1.100 BSC		27.94 BSC	
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.872	0.888	22.15	22.55
N	0.871	0.889	19.30	22.60
Q	Ø .118	Ø .138	Ø 3.00	Ø 3.51
R	0.515	0.525	13.10	13.30
S	0.515	0.525	13.10	13.30
aaa	0.007 REF		0.178 REF	
bbb	0.010 REF		0.254 REF	
ccc	0.015 REF		0.381 REF	

- STYLE 1:
PIN 1. DRAIN
2. GATE
3. SOURCE



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.905	0.915	22.99	23.24
B	0.535	0.545	13.60	13.80
C	0.147	0.200	3.73	5.08
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.872	0.888	22.15	22.55
N	0.871	0.889	19.30	22.60
R	0.515	0.525	13.10	13.30
S	0.515	0.525	13.10	13.30
aaa	0.007 REF		0.178 REF	
bbb	0.010 REF		0.254 REF	
ccc	0.015 REF		0.381 REF	

- STYLE 1:
PIN 1. DRAIN
2. GATE
3. SOURCE

PRODUCT DOCUMENTATION

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Refer to the following documents to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

REVISION HISTORY

The following table summarizes revisions to this document.

Date	Revision Number	Description
Sept. 2006	0	<ul style="list-style-type: none">• Initial Release of Data Sheet

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